


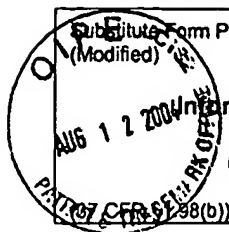
Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. <b>12852-023001</b>	Application No. <b>10/806,689</b>
	Applicant <b>Mitsuaki Nishie et al.</b>		
	Filing Date <b>March 23, 2004</b>	Group Art Unit <b>2633</b>	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
JH	AD	2000-028850	01/28/2000	Japan			X	
	AE	09-325248	12/16/1997	Japan			X	
	AF	2003-004991	01/08/2003	Japan			X	
	AG	2000-249875	09/14/2000	Japan			X	
	AH	2000-180671	06/30/2000	Japan			X	
	AI	10153720	06/09/1998	Japan			X	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AJ	
	AK	
	AL	
	AM	

Examiner Signature 	Date Considered <b>3-15-06</b>
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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
JR	AA	5,841,562	11/24/1998	Rangwala et al.			
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